

Radiations on Gaia

Native and irradiated Charge Transfer Inefficiency characterization

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All the space you need

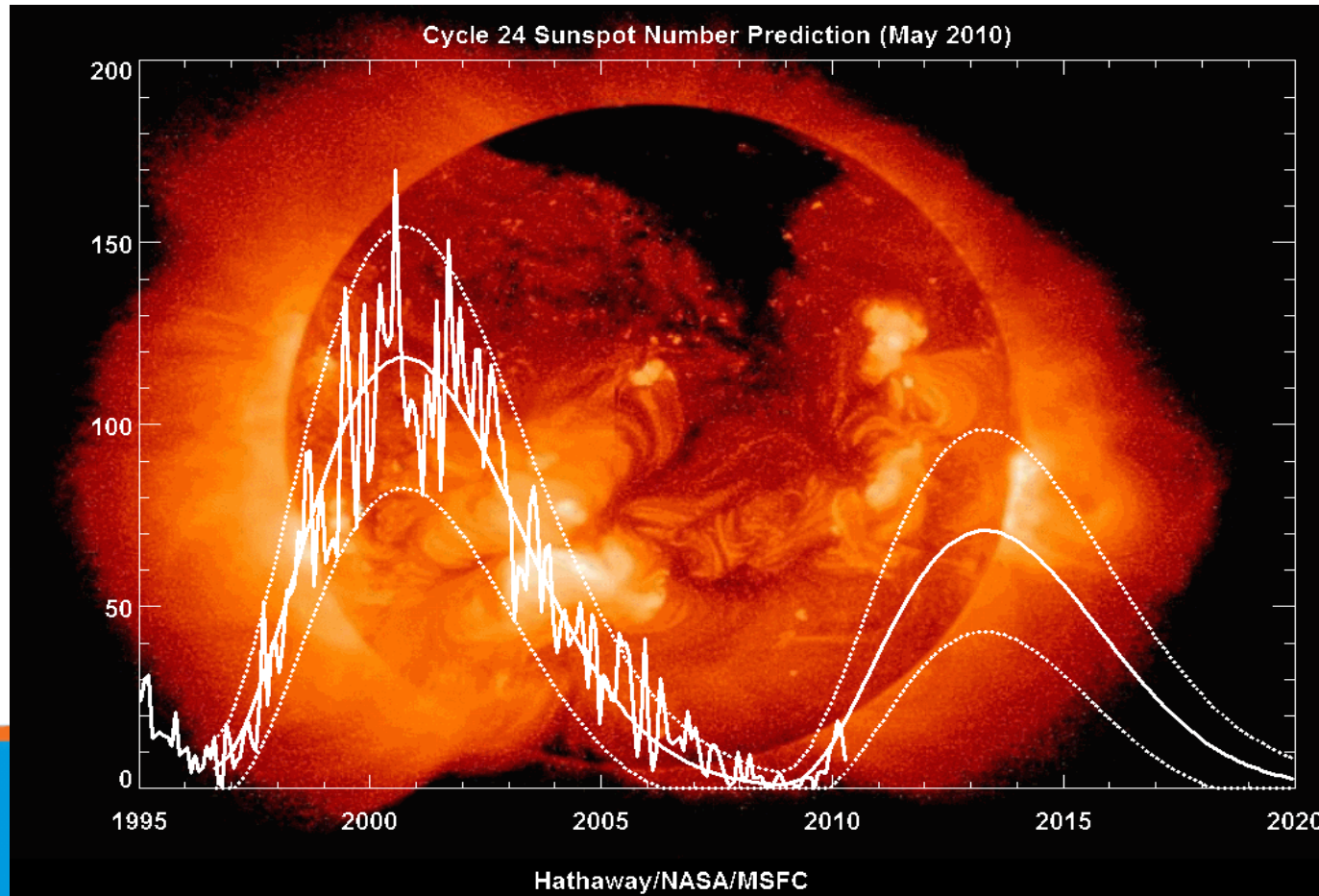


Radiations on Gaia

- The impact on science data
- The radiation test bench
- Test results
- Modelling & calibration
- Conclusion

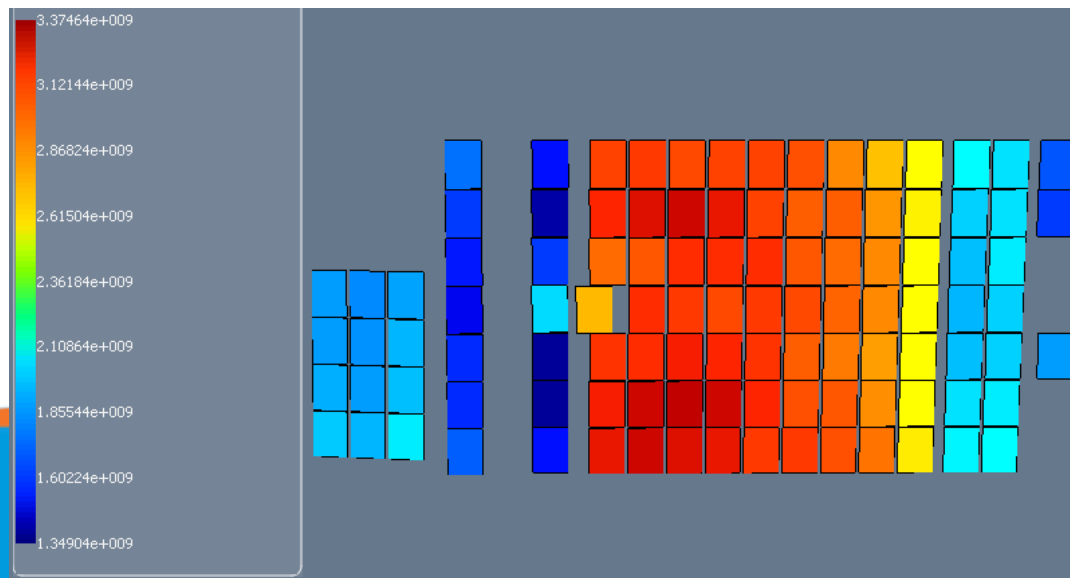
The impact on science data

- The environment



The impact on science data

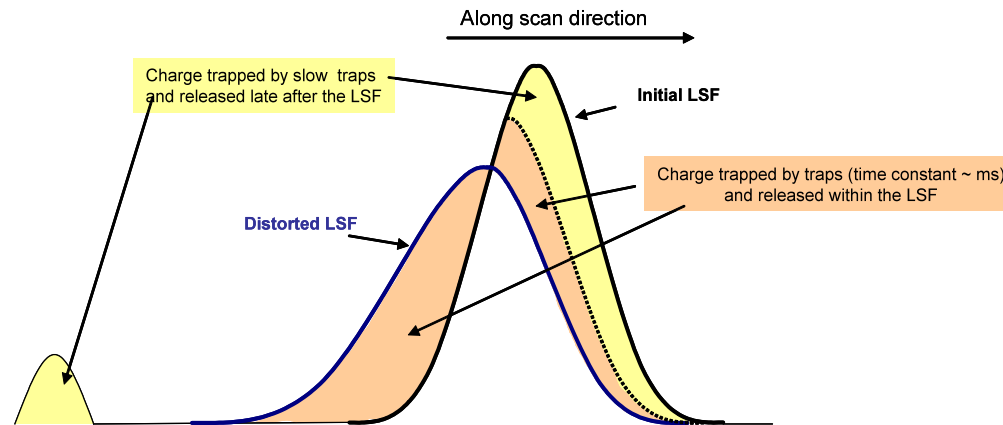
- The environment
 - The solar activity is minimal today, but...
 - Current estimations predict that the new cycle will have its maximum during the Gaia mission
 - The associated particles flux (mainly solar protons) will damage the CCDs and corrupt the science data



Simulated particle flux in part/cm² at end of mission

The impact on science data

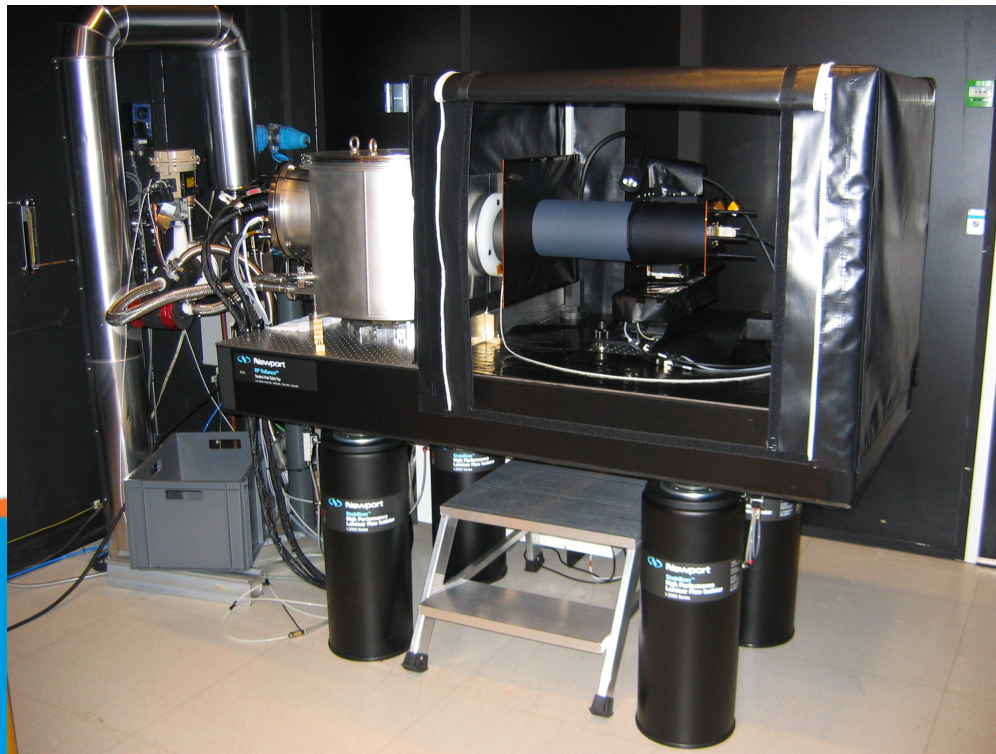
- The raw data gets corrupted
 - Degradation of the signal to noise ratio
 - Distortion of the signal during the TDI transfer



- Impacts needing quantitative characterization
 - Centroiding & magnitude bias in astrometry
 - Radial velocity bias in RVS
 - Spectral mixing in photometry and RVS

The radiation test bench

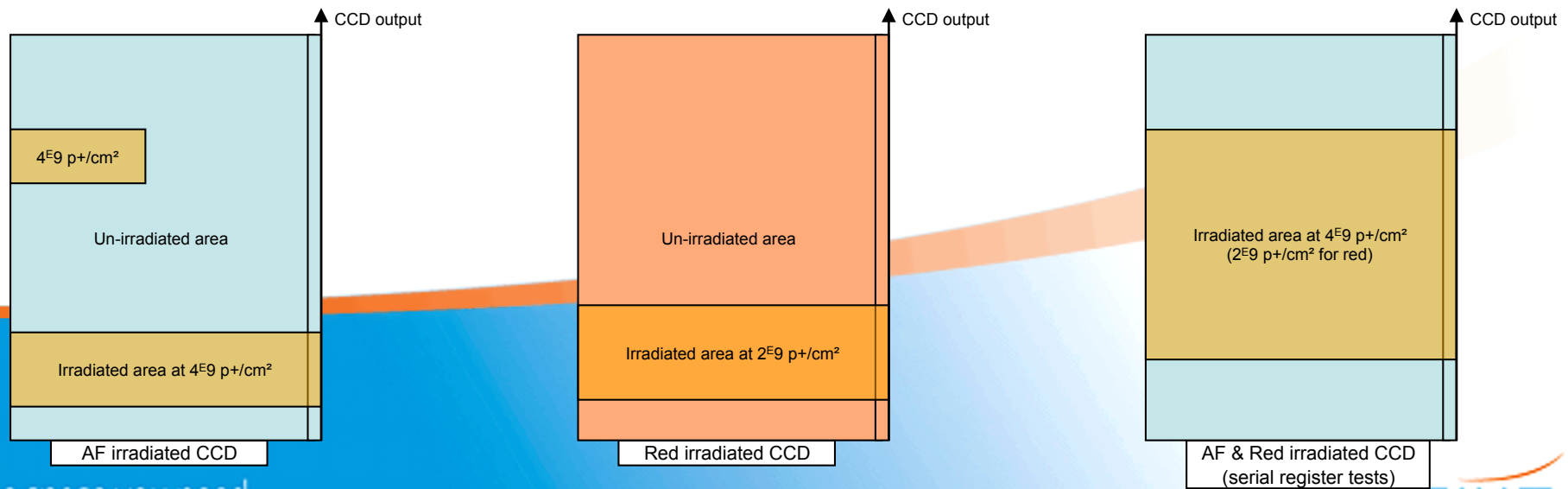
- Internal tests from 2004
- New test bench developed from 2008 under ESA funding
- Objective: to characterize the radiations effects on representative Gaia CCDs

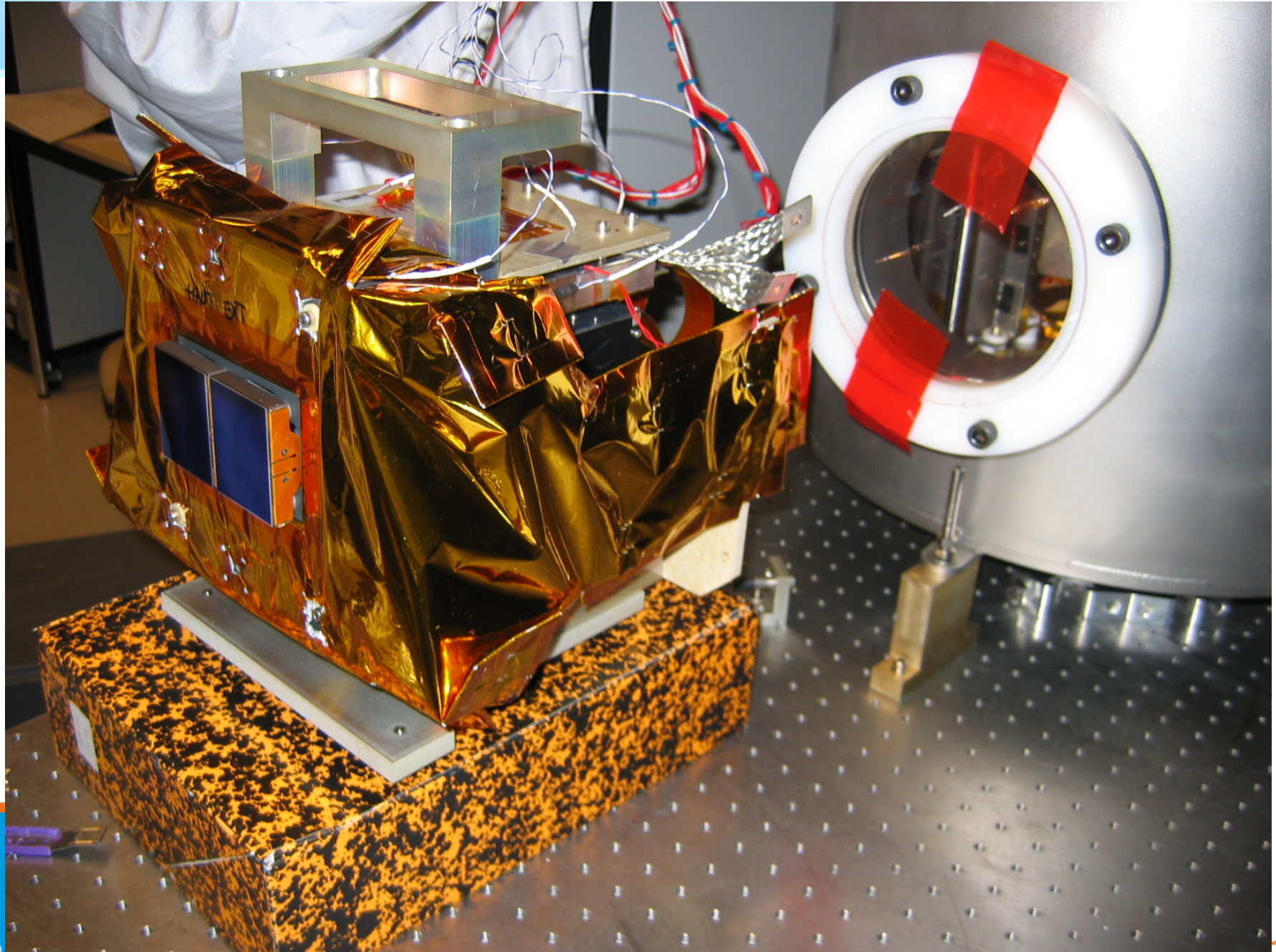


The radiation test bench

■ Main components

- LN₂ cooling tank and irradiated CCDs
- Driving electronics (Crisa PEM)
- Optical masks
- Optical source (mask & diffuse optical background)
- Translation baseplate and mechanisms (for TDI motion + all axis)

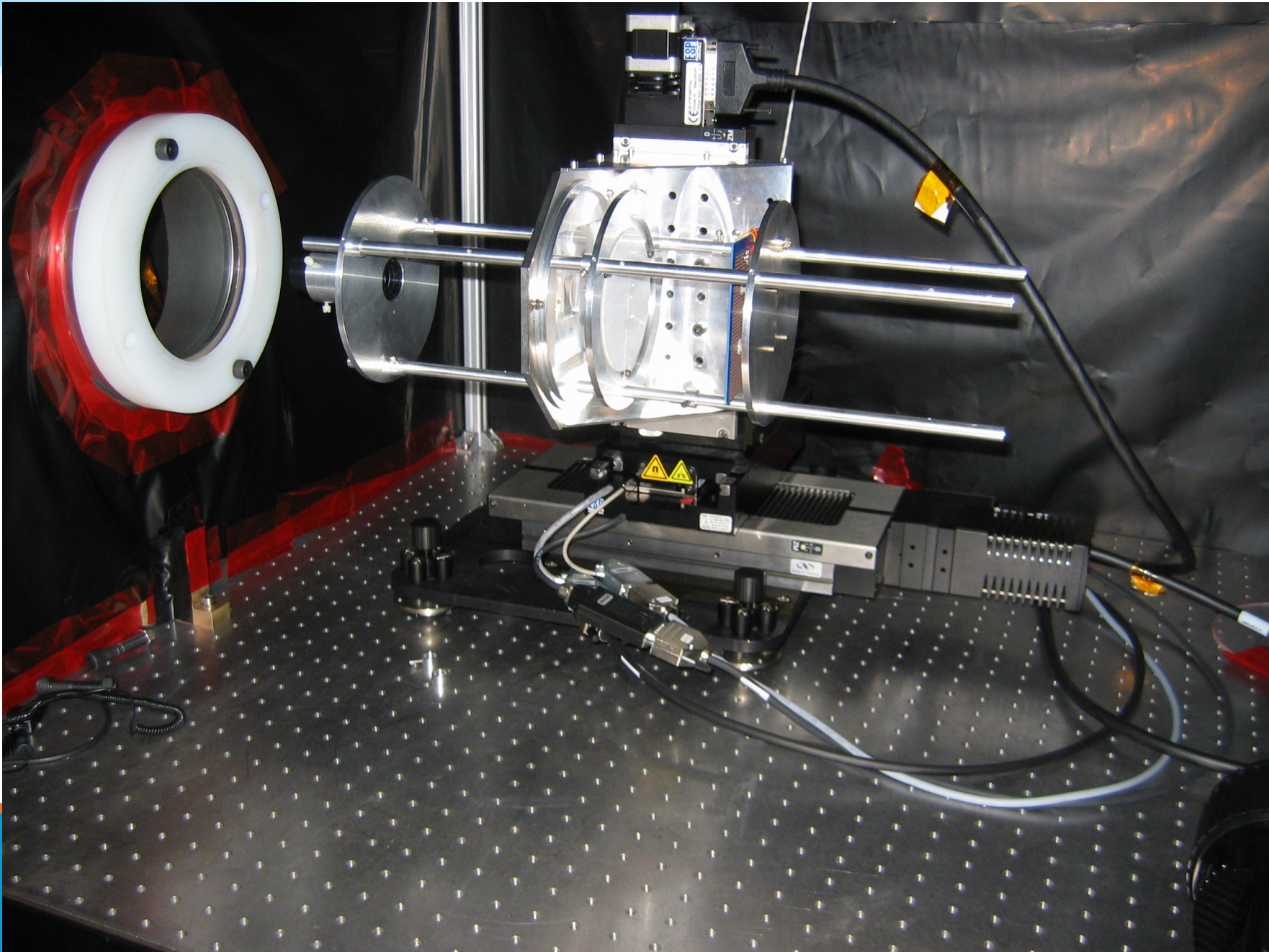




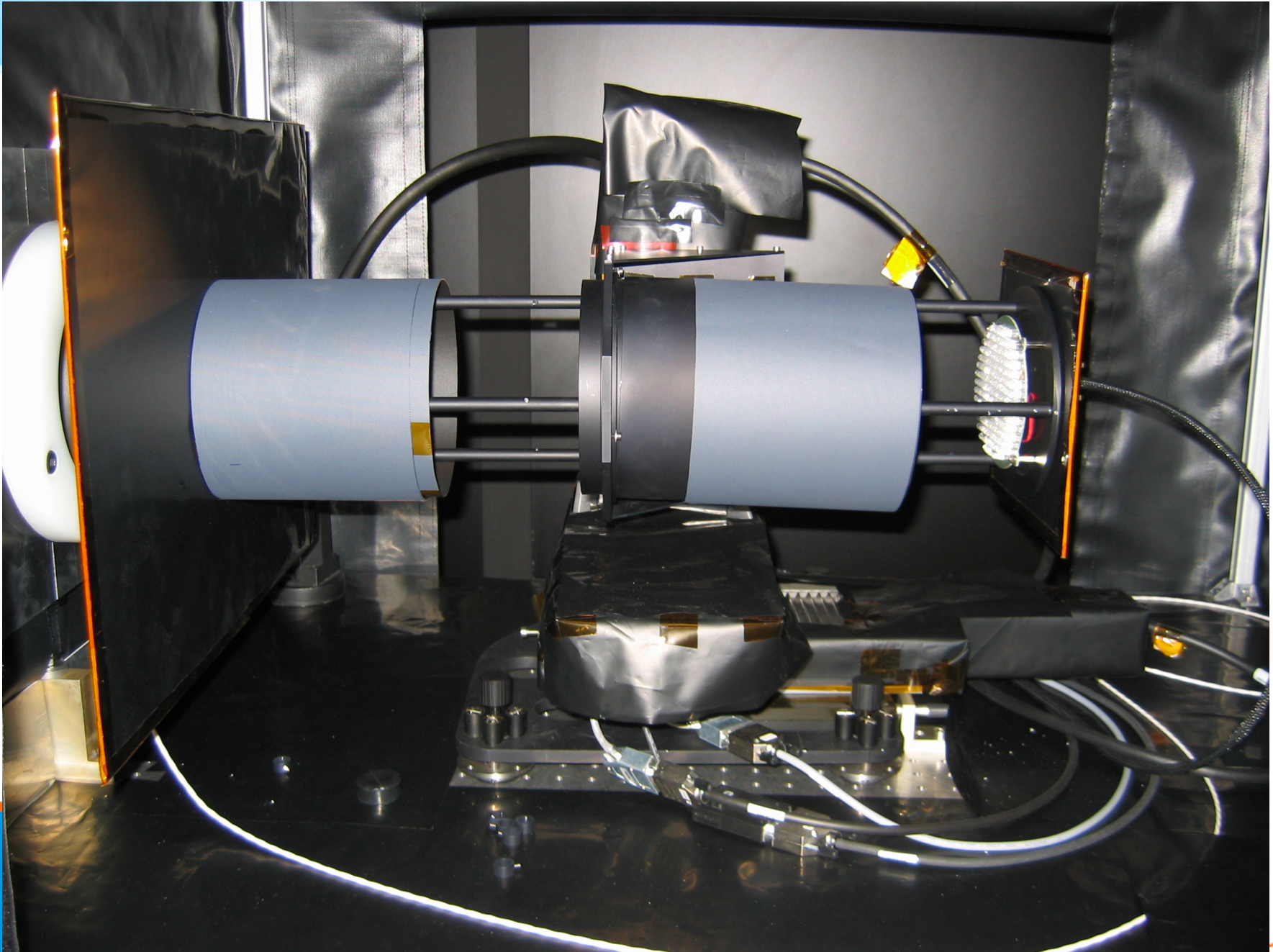
All the space you need



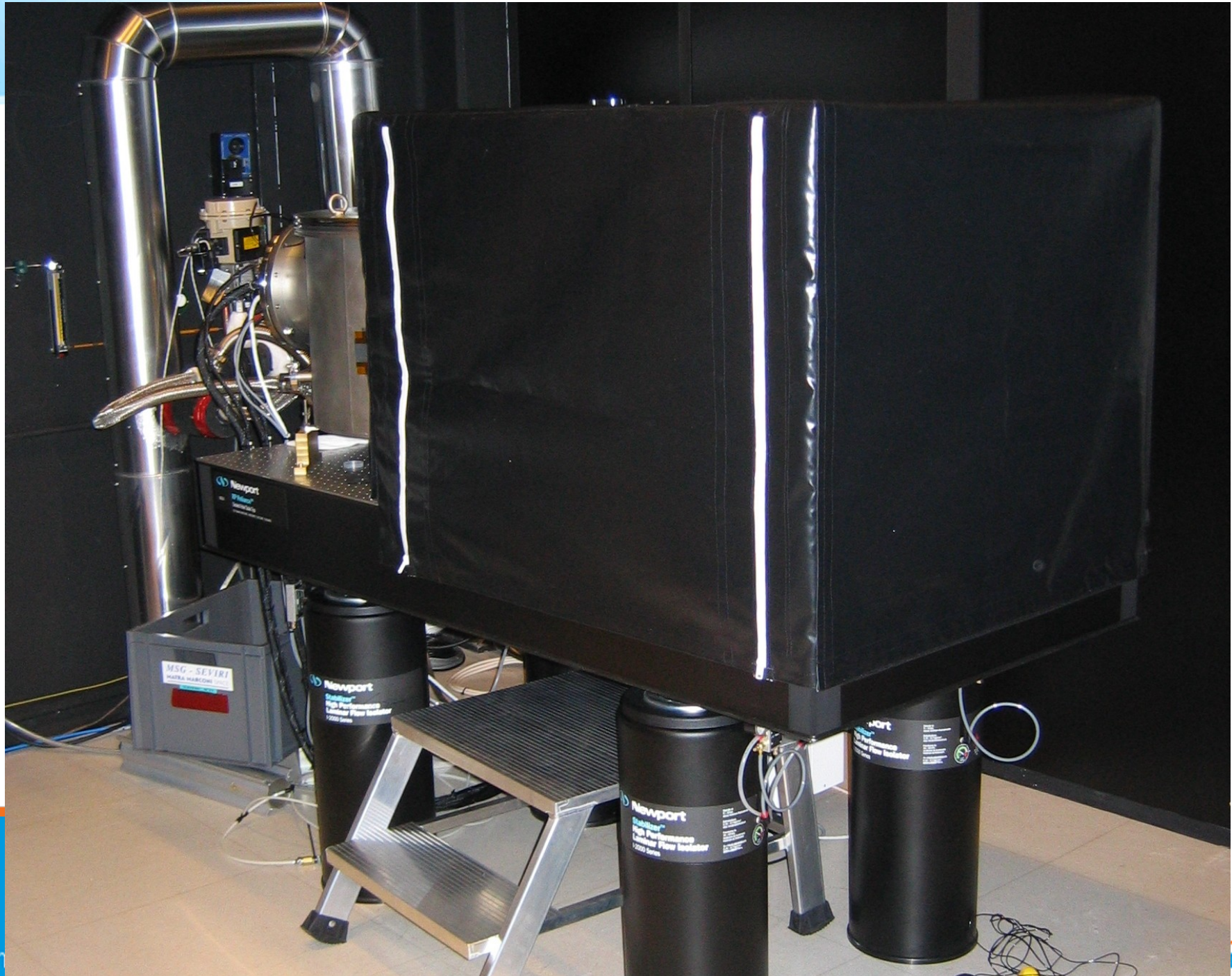
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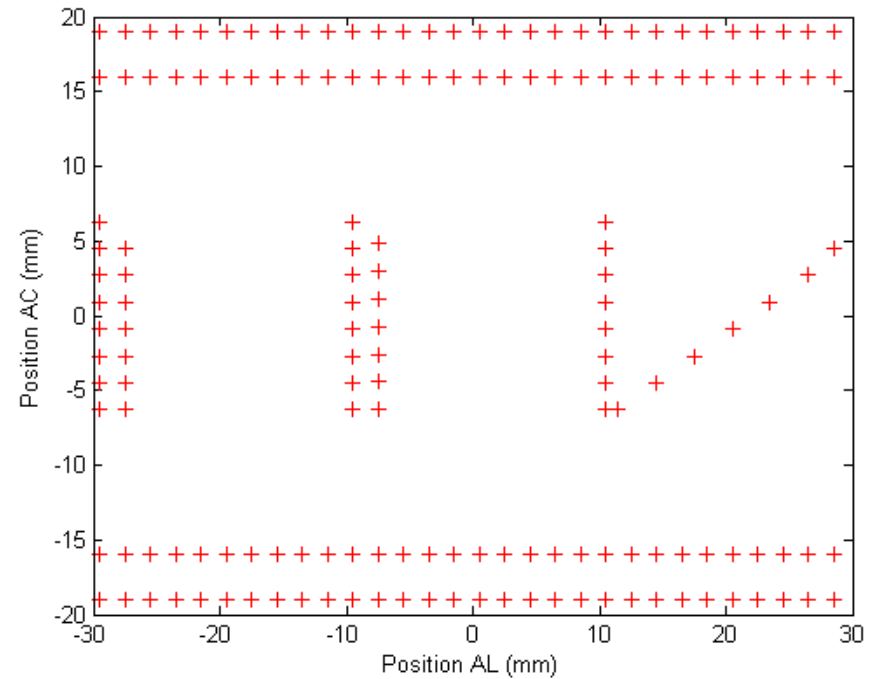
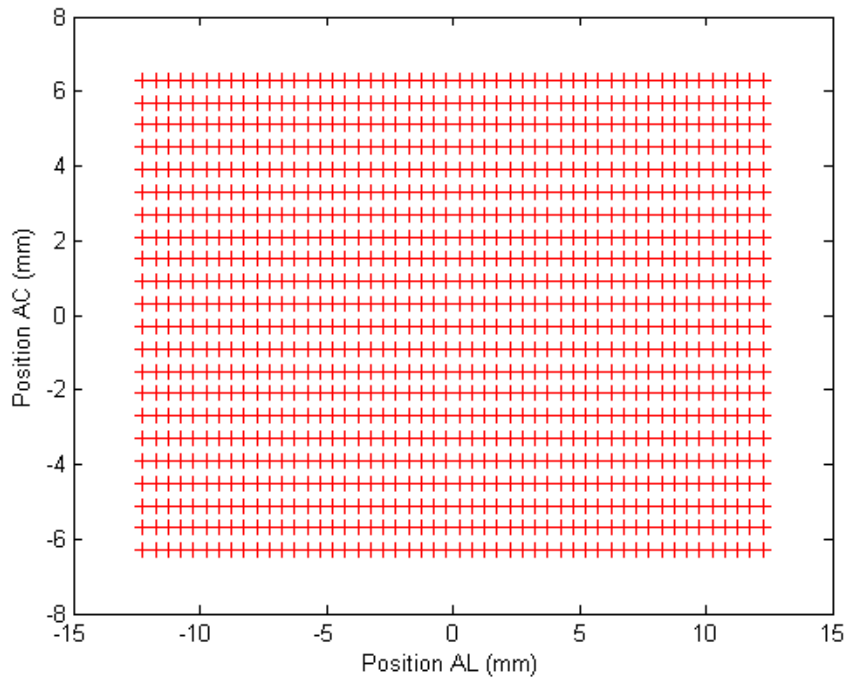


All the space you need



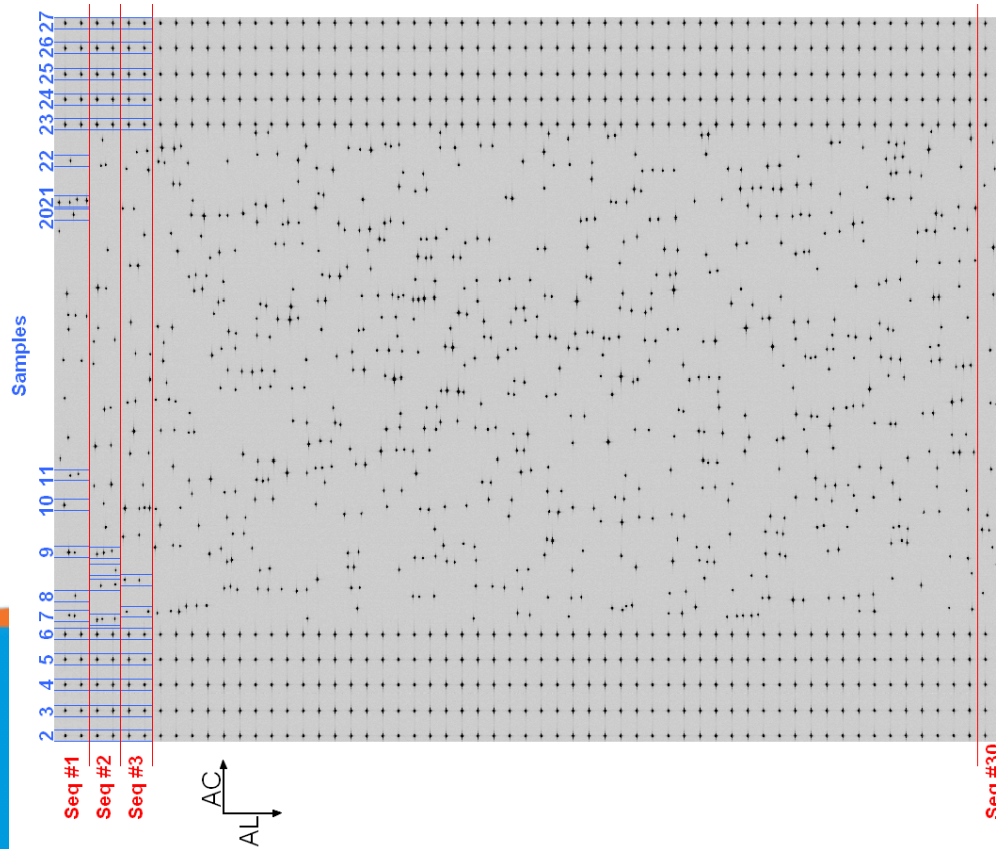
The radiation test bench

- Optical masks
 - Representative stimuli for AF, XP, & RVS
- Academic configurations:



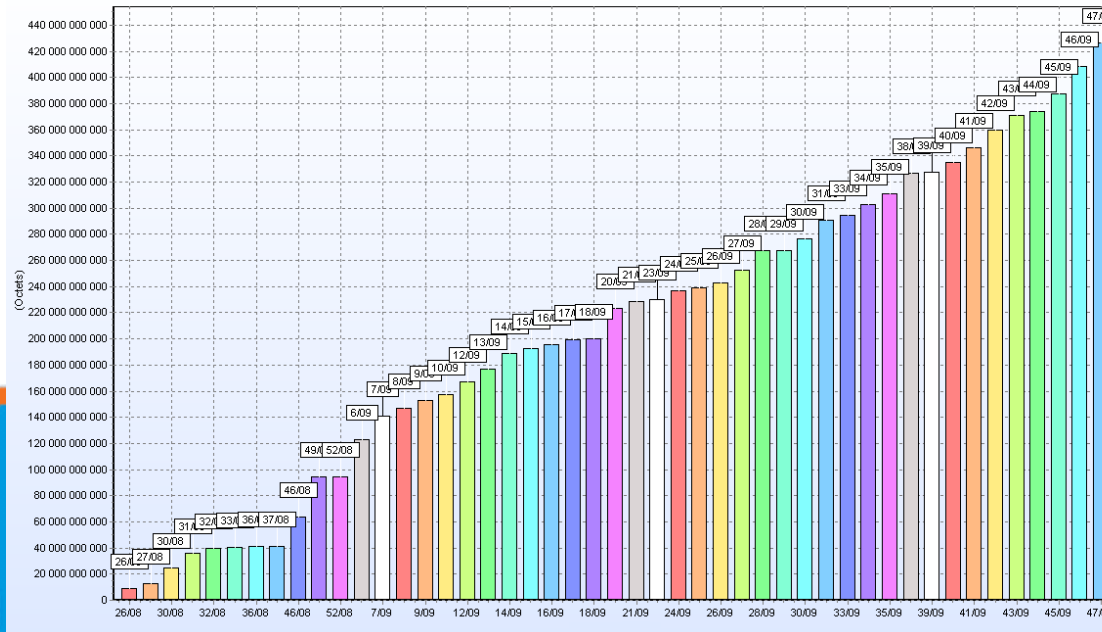
The radiation test bench

- Optical masks
 - Representative stimuli for AF, XP, & RVS
- Sky-like configuration:



The radiation test bench

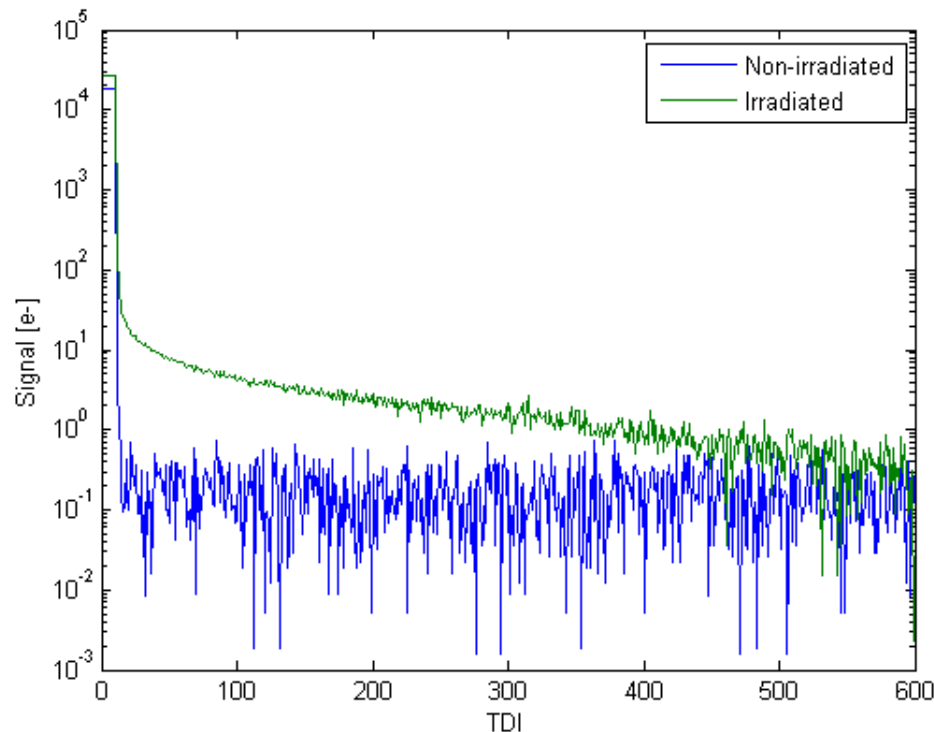
- A few figures
 - 2 years of almost continuous operation
 - 400 Gigabytes of raw data
 - Thousands of line of code
 - Thousands of liters of liquid nitrogen
 - >200.000 transits



Test results

■ Charge injection

- Used to “fill” the traps induced by the radiations
- Resets the history of the CCD and limits the radiation effects
- Charge trail used to estimate the characteristics of the traps

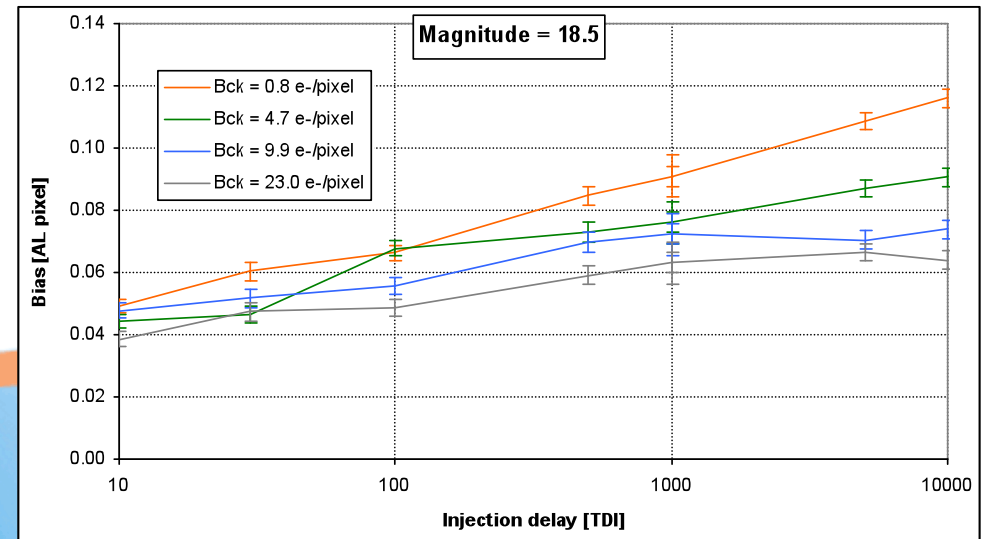
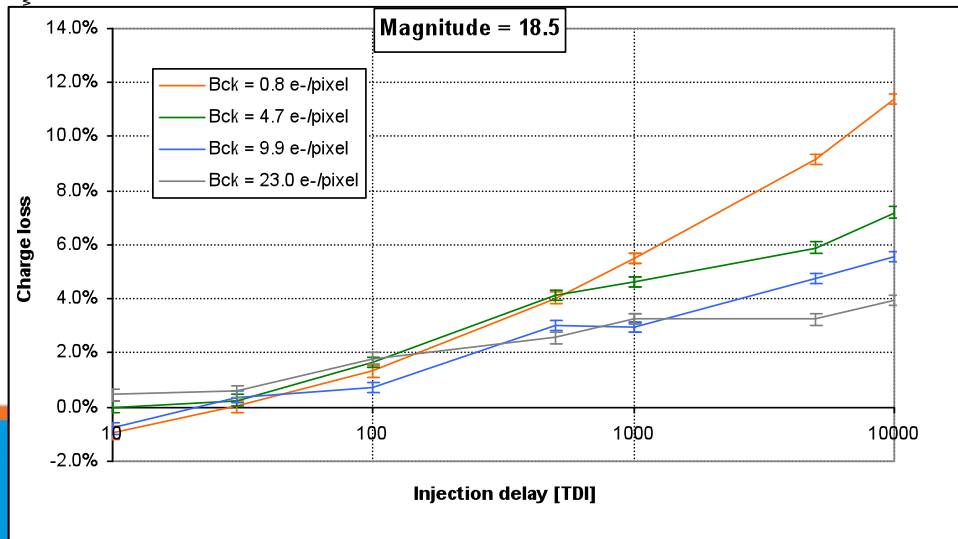


Typical flight configuration:

- Level = 20 ke-/pixel
- Period = 1 sec
- Duration = 4 TDI

Test results

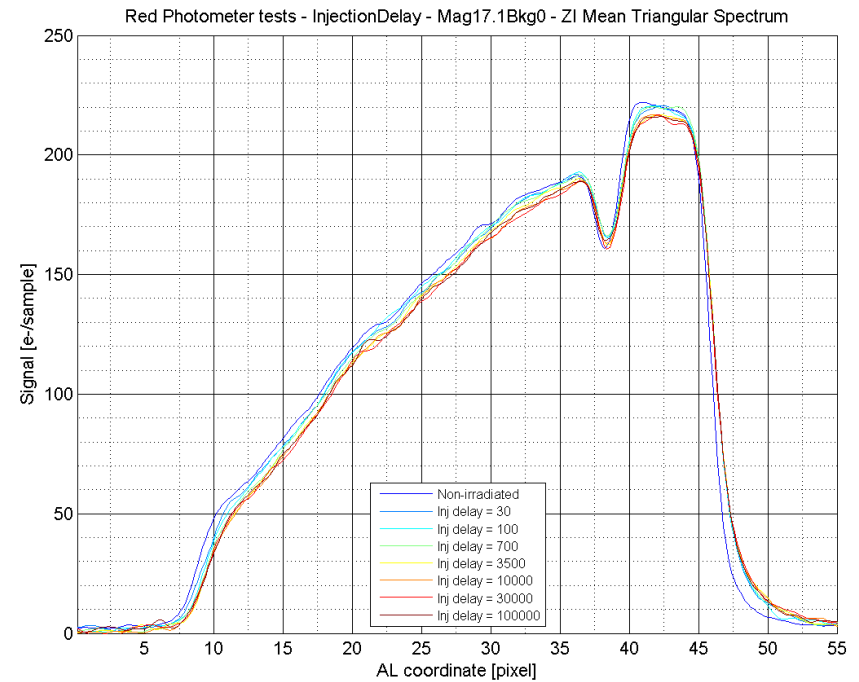
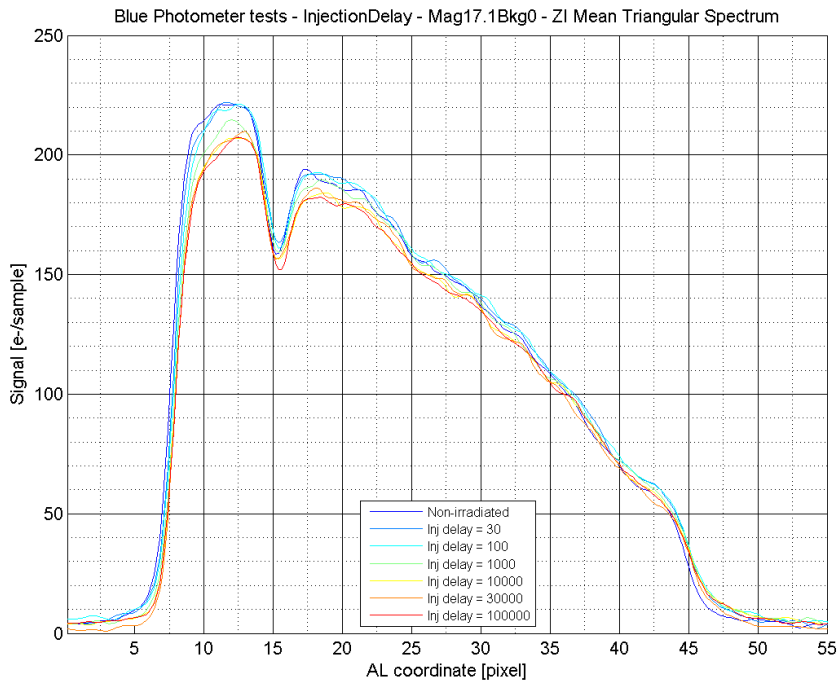
- Line spread function
 - Strong variability of the radiations effects
 - Bias & charge loss depend on the magnitude, injection delay, background
 - Centroiding bias up to 0.2 AL pixels for the faintest stars



Test results

■ BP & RP spectra

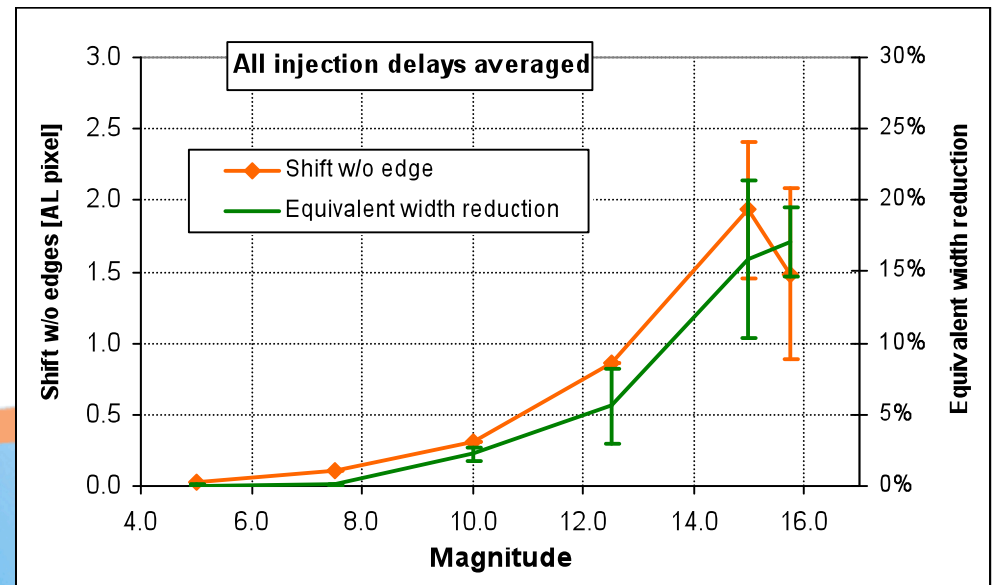
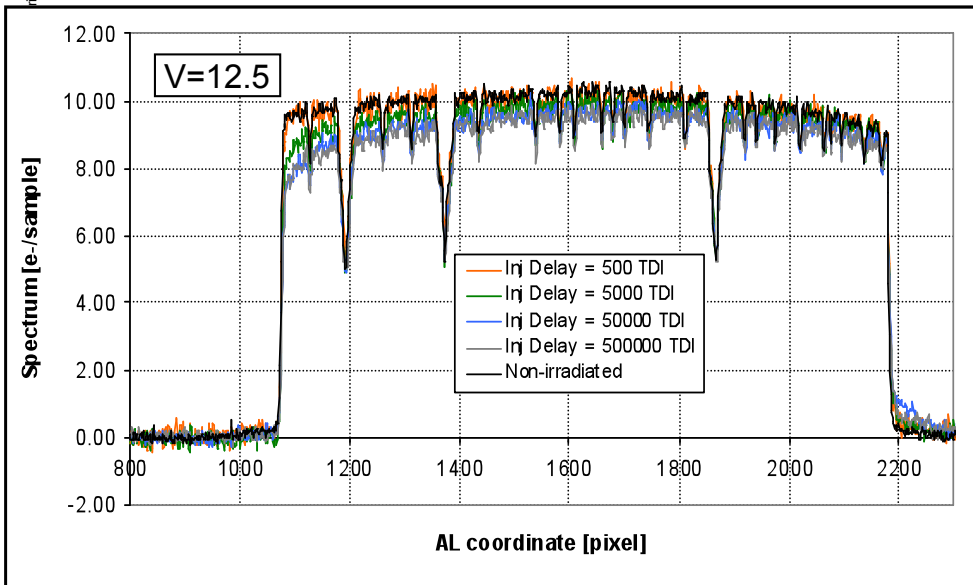
- Charge loss of a few percent (<10%) to be expected in flight
- Spectral mixing: charges transferred from one band to another



Test results

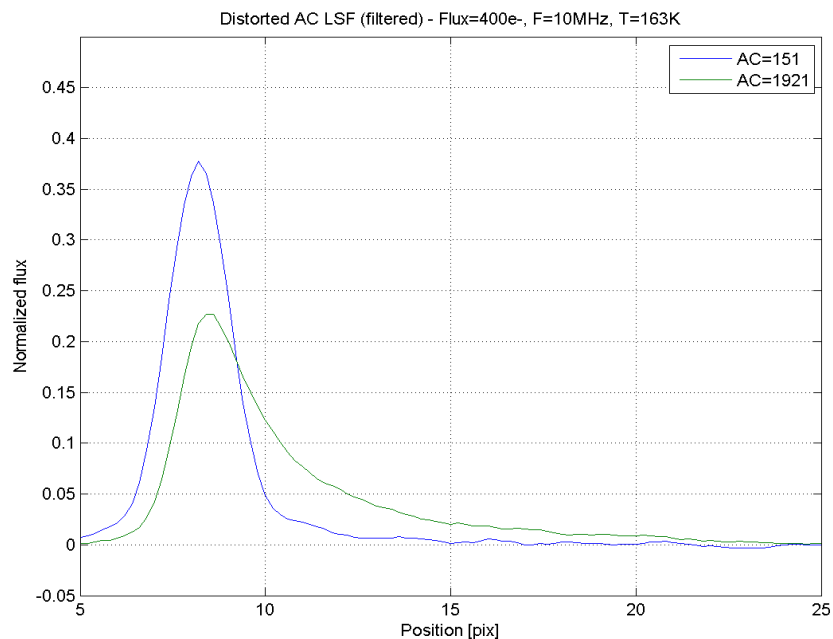
■ RVS spectrum

- Degradation of the signal to noise ratio
- Spectral lines filled up to ~20% at $V=15.75$
- Induced radial velocity bias up to ~20 km/s
- Charge injection not used in flight for RVS



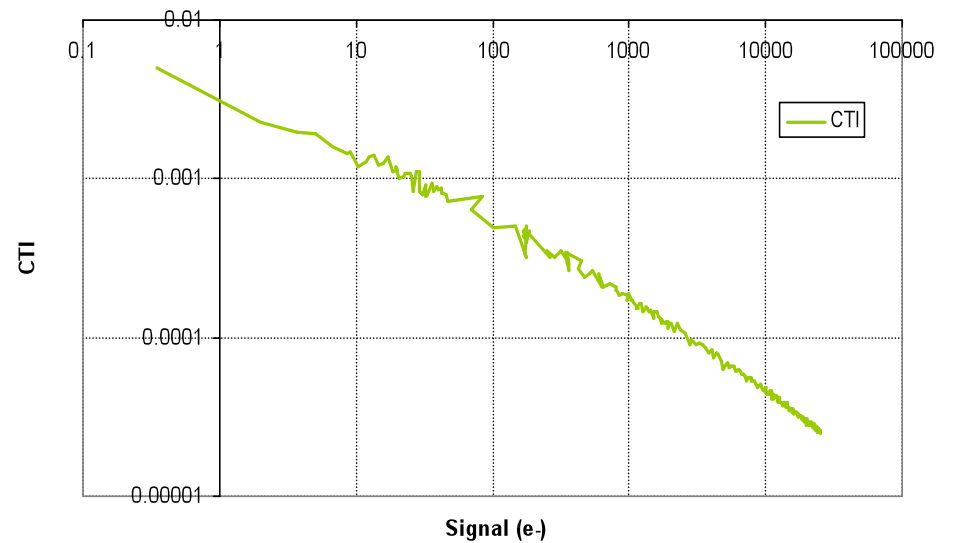
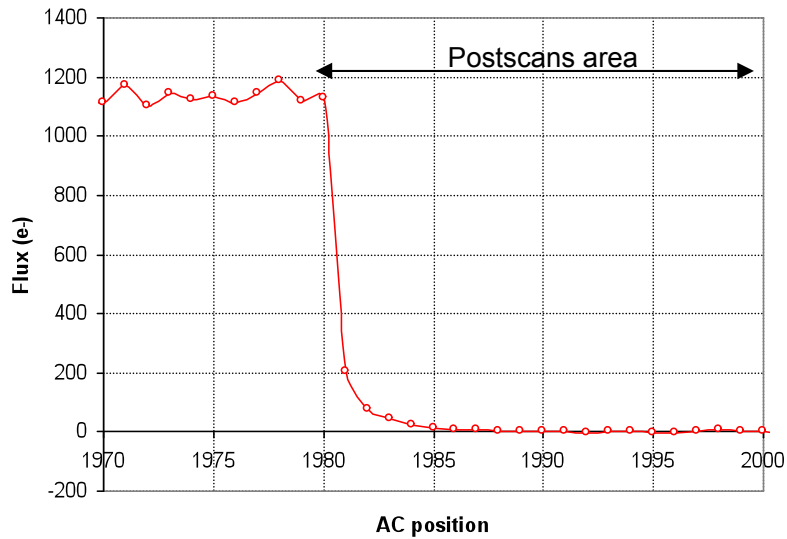
Test results

- Native (un-irradiated) CTI
 - Very low in the AL direction
 - Much higher in the AC direction (serial register)
Main cause: very fast pixel flushing at 10 MHz
 - Generates additional charge loss: flux lost outside the AC bounds of the window



Test results

- Serial register CTI: measurement technique
 - Flatfield illumination of the CCD
 - Acquisition & summation of the charges trailed in the postscans (postscans = un-illuminated virtual pixels at the end of image zone)
 - CTI is function of the illumination level



Test results

- Optimal temperature
 - FPA design temperature: 163K
 - Image zone radiation effects are higher when T_{CCD} increases
 - But: serial register transfer improves
 - 163K ~ optimal setting for the mission

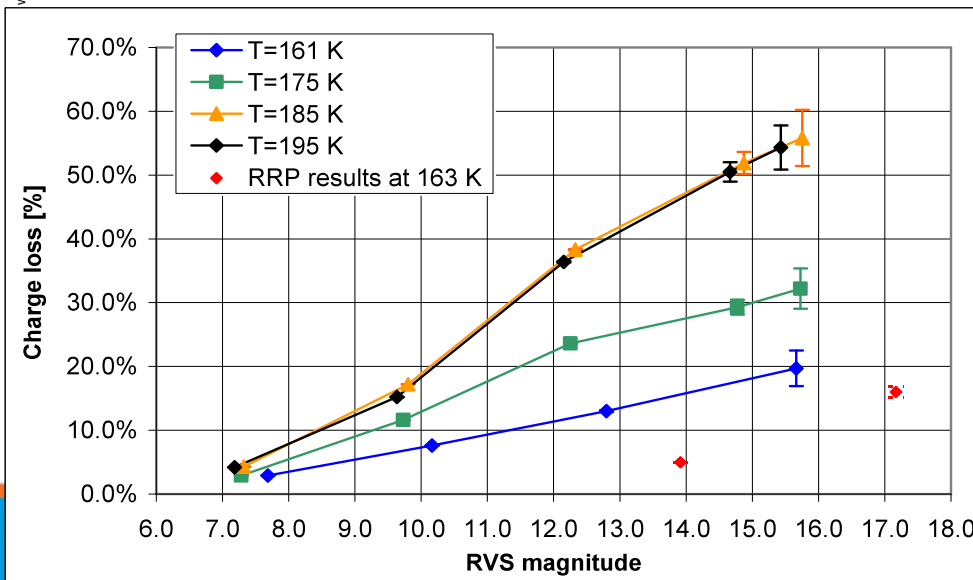
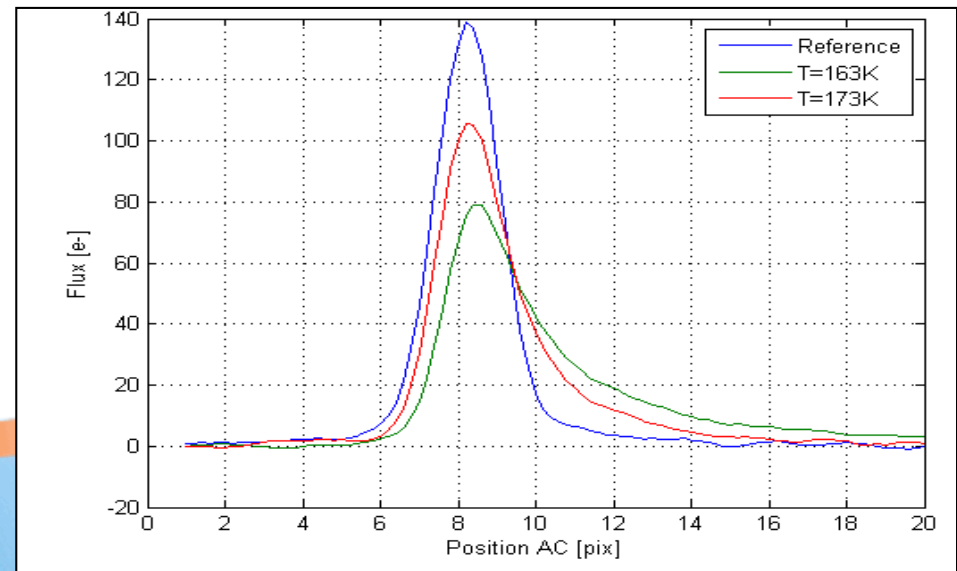


Image zone – RVS radiation charge loss



Serial register – AC LSF distortion

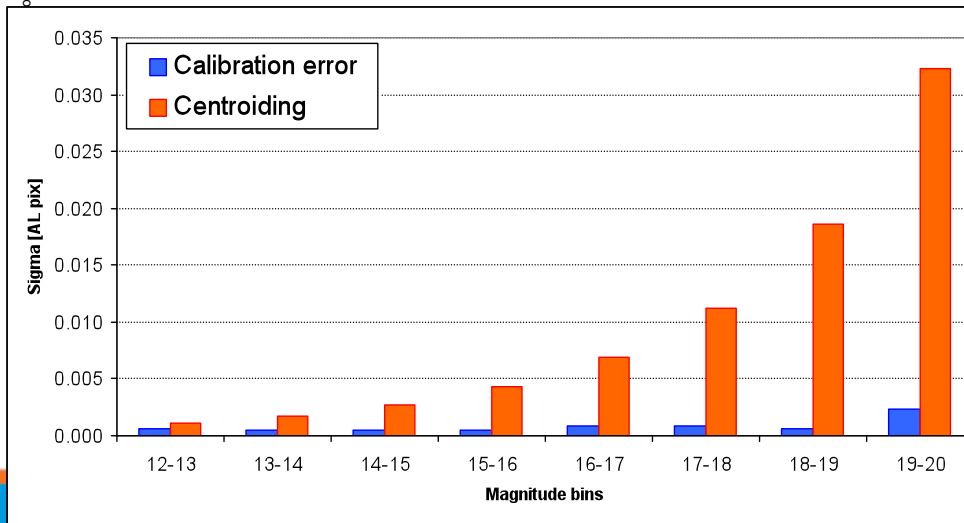
Modelling & calibration

- Objectives of these tests
 - Characterize of the radiation effects
 - Provide input data for the demonstration that on-ground calibration is feasible

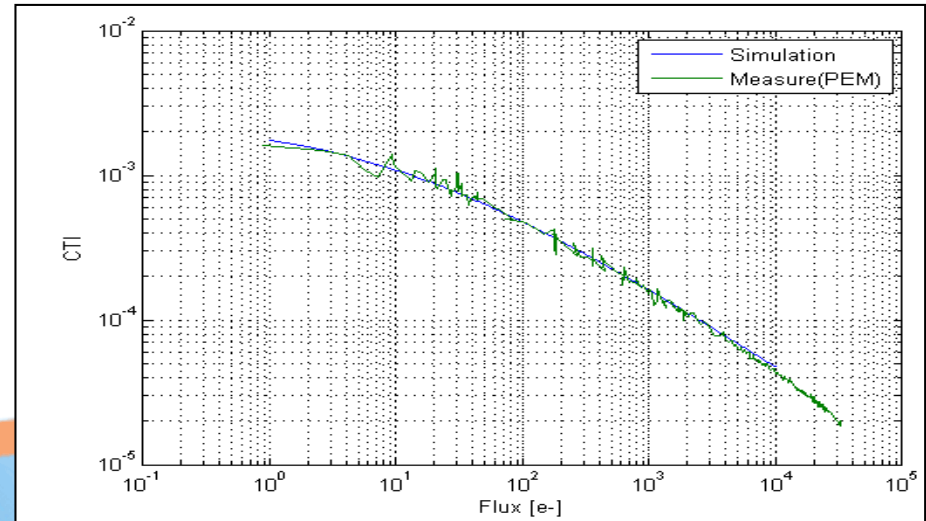
- Activity carried out by the Radiation Calibration Working Group:
 - ESA project
 - EADS Astrium
 - DPAC scientists from the different CU
 - ELSA PhDs !

Modelling & calibration

- Several physical or empirical models have been developed:
 - Charge Distortion Model (CDM01, 02, 03)
 - Pixel modelling (volume occupied by the charges)
 - $Bias \propto \sum \alpha_{ij} G^i \log(ID)^j$
- Good agreement with the test data:



Astrometric calibration errors



CDM02 fitting of serial register data

Conclusion

- Tests are still on-going: radiation campaign #4
 - Irradiated serial register tests
 - Persistency tests
 - RVS tests in LR mode
- Thanks to the work already done, we've reached a better understanding of the radiations, and their impact on Gaia
- There is now more confidence in the radiation calibration process, and its limited impact on the performances
 - Ex: calibration errors <15% on the astrometric budget